

**Search Notes**

Application/Control No.

10/706,503

Examiner

Christopher M. Koehler

Applicant(s)/Patent under  
Reexamination

PARK, IL-YONG

Art Unit

3726

**SEARCHED**

Class	Subclass	Date	Examiner
451	527-530 533 534 539 29-31	5/23/2006	CMK
132	76.4 76.5	5/23/2006	CMK
132	73	5/23/2006	CMK
407	29.1	5/23/2006	CMK
407	29.14	5/23/2006	CMK
407	29.15	5/23/2006	CMK
29	527.1	5/23/2006	CMK
29	527.2	5/23/2006	CMK
29	DIG.12	5/23/2006	CMK
427	258 259	5/23/2006	CMK
427	261 282	5/23/2006	CMK
427	287 438	5/23/2006	CMK
427	468 470	5/23/2006	CMK
427	526 531	5/23/2006	CMK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name and IDS search	5/23/2006	CMK
EAST text, FWD, BKWD search notes attached	5/23/2006	CMK

**Search Notes (continued)**

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Class	Subclass	Date	Examiner
427	202-206 214 216 217	5/23/2006	CMK
205	205-229	5/23/2006	CMK
205	271 135	5/23/2006	CMK
51	295	5/23/2006	CMK

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Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR